

<b>INFORMATION DISCLOSURE STATEMENT TRANSMITTAL</b>				<b>Application Number</b> <div style="font-size: 1.2em; font-weight: bold;">10/540068</div>	
To Commissioner For Patents Enclosed herewith is a Form PTO-1449, any required copies of documents listed thereon, and any concise explanation of their relevance is indicated below per 37 CFR 1.97.				<b>Filing Date</b> 	
				<b>First Named Inventor</b> Johannes VAN WINGERDEN	
				<b>Group Art Unit</b> 	
				<b>Examiner Name</b> 	
				<b>Atty. Docket Number</b> NL02 1489 US	

  

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. <sup>1</sup>	Document Number No.-Kind Code <sup>2</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns Lines, Where Relevant Passages or Relevant Figures Appear
/R.A./		US- 2002/085297	07-04-2002	VOWES STEVE W ET AL	
↓		US- 6 272 392	08-07-2001	CAPODIECI LUIGI	
/R.A./		US- 6 478 484	11-12-2002	SINGH BHANWAR	
		US-			
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FOREIGN PATENT DOCUMENTS						
Examiner Initials*	Cite No. <sup>1</sup>	Document Number (ctry <sup>3</sup> -no. <sup>4</sup> -kind <sup>5</sup> , if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of cited document	Pages, Columns Lines, Where Relevant Passages or Relevant Figures Appear	T <sup>6</sup>
/R.A./		WO 01/84382	11-08-2001	KLA TENCOR INC.		
/R.A./		EP 1 271 246	01-02-2003	INFINEON TECHNOLOGIES		

  

NON-PATENT LITERATURE DOCUMENTS						
Examiner Initials*	Cite No. <sup>1</sup>	Include name of the author (in capital letters), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.				T <sup>6</sup>
/R.A./		NANAKLI S ET AL: "COMBINATION MULTIPLE FOCAL PLANES AND PSM FOR SUB 120 NM NODE WITH KfR LITHOGRAPHY: STUDY OF THE PROXIMITY EFFECTS" MICROELECTRONIC ENGINEERING, ELSEVIER PUBLISHERS BV, VOL. 61-62, JULY 2002, PAGES 123-132				
/R.A./		MACK C A ET AL: "DATA ANALYSIS FOR PHOTOLITHOGRAPHY" MICROELECTRONIC ENGINEERING, ELSEVIER PUBLISHERS BV, VOL. 64, NO. 1-4, MAY 1999, PAGES 65-68				

  

<b>Examiner Signature</b>	/Rashid Alam/	<b>Date Considered</b>	08/11/2008
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\* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

<sup>1</sup> Unique citation designation number. <sup>2</sup> See attached Kinds of U.S. Patent Documents. <sup>3</sup> Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). <sup>4</sup> For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. <sup>5</sup> Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. <sup>6</sup> Applicant is to place a check mark here if English language Translation is attached.